

**TAIMAO**

ShenzhenTaimaoTechnology Co.,Ltd.  
**SOT-23 Plastic-Encapsulate MOSFETs**

**2N7002K N-channel MOSFET**

**FEATURES**

- High density cell design for Low  $R_{DS(on)}$
- Voltage controlled small signal switch
- Rugged and reliable
- High saturation current capability
- ESD protected up to 2KV

**Marking: 72K**

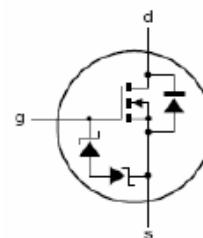
**MOSFET MAXIMUM RATINGS ( $T_a = 25^\circ\text{C}$  unless otherwise noted)**

| Symbol          | Parameter                                   | Value   | Units                     |
|-----------------|---|---------|---------------------------|
| $V_{DS}$        | Drain-Source voltage                        | 60      | V                         |
| $I_D$           | Drain Current                               | 340     | mA                        |
| $P_D$           | Power Dissipation                           | 0.35    | W                         |
| $T_J$           | Junction Temperature                        | 150     | $^\circ\text{C}$          |
| $T_{stg}$       | Storage Temperature                         | -55-150 | $^\circ\text{C}$          |
| $R_{\theta JA}$ | Thermal Resistance from Junction to Ambient | 357     | $^\circ\text{C}/\text{W}$ |

**SOT-23**

1. GATE
2. SOURCE
3. DRAIN

**Equivalent circuit**



**MOSFET ELECTRICAL CHARACTERISTICS ( $T_a=25^\circ\text{C}$  unless otherwise specified)**

| Parameter                          | Symbol       | Test Condition   | Min        | Typ | Max       | Units         |
|------------------------------------|--------------|--|------------|-----|-----------|---------------|
| <b>Static Characteristics</b>      |              |  |            |     |           |               |
| Drain-Source Breakdown Voltage     | $V_{DS}$     | $V_{GS} = 0V, I_D = 250\mu\text{A}$                                      | 60         |     |           | V             |
| Gate Threshold Voltage*            | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = 1\text{mA}$                                      | 1          |     |           | V             |
| Zero Gate Voltage Drain Current    | $I_{DSS}$    | $V_{DS} = 48V, V_{GS} = 0V$  |            |     | 1         | $\mu\text{A}$ |
| Gate –Source leakage current       | $I_{GSS1}$   | $V_{GS} = \pm 20V, V_{DS} = 0V$  |            |     | $\pm 10$  | $\mu\text{A}$ |
|                                    | $I_{GSS2}$   | $V_{GS} = \pm 10V, V_{DS} = 0V$  |            |     | $\pm 200$ | nA            |
|                                    | $I_{GSS3}$   | $V_{GS} = \pm 5V, V_{DS} = 0V$   |            |     | $\pm 100$ | nA            |
| Drain-Source On-Resistance*        | $R_{DS(on)}$ | $V_{GS} = 4.5V, I_D = 200\text{mA}$                                      |            |     | 5.3       | $\Omega$      |
|                                    |              | $V_{GS} = 10V, I_D = 500\text{mA}$                                       |            |     | 5         | $\Omega$      |
| Diode Forward Voltage              | $V_{SD}$     | $V_{GS}=0V, I_S=300\text{mA}$  |            |     | 1.5       | V             |
| Recovered charge                   | $Q_r$        | $V_{GS}=0V, I_S=300\text{mA}, V_R=25V, dI_S/dt=-100\text{A}/\mu\text{s}$ |            | 30  |           | nC            |
| <b>Dynamic Characteristics**</b>   |              |  |            |     |           |               |
| Input Capacitance                  | $C_{iss}$    | $V_{DS} = 10V, V_{GS} = 0V, f = 1\text{MHz}$                             |            |     | 40        | pF            |
| Output Capacitance                 | $C_{oss}$    |  |            |     | 30        | pF            |
| Reverse Transfer Capacitance       | $C_{rss}$    |  |            |     | 10        | pF            |
| <b>Switching Characteristics**</b> |              |  |            |     |           |               |
| Turn-On Delay Time                 | $t_{d(on)}$  | $V_{GS}=10V, V_{DD}=50V, R_G=50\Omega, R_{GS}=50\Omega, R_L=250\Omega$   |            |     | 10        | ns            |
| Turn-Off Delay Time                | $t_{d(off)}$ |  |            |     | 15        | ns            |
| Reverse recovery Time              | $t_{rr}$     | $V_{GS}=0V, I_S=300\text{mA}, V_R=25V, dI_S/dt=-100\text{A}/\mu\text{s}$ |            | 30  |           | ns            |
| <b>GATE-SOURCE ZENER DIODE</b>     |              |  |            |     |           |               |
| Gate-Source Breakdown Voltage      | $BV_{GS0}$   | $I_{GS}=\pm 1\text{mA}$ (Open Drain)                                     | $\pm 21.5$ |     | $\pm 30$  | V             |

**Notes :**

\*Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .

\*\*These parameters have no way to verify.

# Typical Characteristics

2N7002K

